

<b>Notice of References Cited</b>			Application/Control No.	Applicant(s)/Patent Under Reexamination CRAGUN ET AL.	
			Examiner SHEW-FEN LIN	Art Unit 2166	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0099552	07-2002	Rubin et al.	704/270
*	B	US-2002/0116420	08-2002	Allam et al.	707/526
*	C	US-2006/0129596	06-2006	Bays et al.	707/102
*	D	US-6,484,156	11-2002	Gupta et al.	707/1
*	E	US-5,548,739	08-1996	Yung, Robert	711/204
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.